

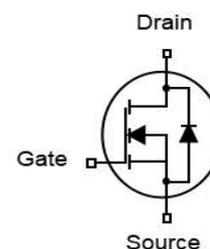
Features

- N-Channel
- Low $R_{DS(on)}$ & FOM
- Extremely low switching loss
- Excellent reliability and uniformity
- Fast switching and soft recovery
- 100% EAS Tested

V_{DS}	30	V
$R_{DS(on),TYP@ V_{GS}=10V}$	0.92	m Ω
$R_{DS(on),TYP@ V_{GS}=4.5V}$	1.25	m Ω
I_D	170	A

DFN5x6


Part ID	Package Type	Marking	Packing
ZTG009N03GC	DFN5x6	ZTG009N03GC	5000pcs/Reel



Absolute Maximum Ratings $T_A = 25^\circ\text{C}$, unless otherwise specified

Symbol	Parameter	Rating	Unit	
Common Ratings ($T_C = 25^\circ\text{C}$ Unless Otherwise Noted)				
V_{GS}	Gate-Source Voltage	± 20	V	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	30	V	
T_J	Maximum Junction Temperature	150	$^\circ\text{C}$	
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$	
I_{DM}	Drain Current-Continuous@ Current-Pulsed (Note 1)	$T_C = 25^\circ\text{C}$ 680	A	
Mounted on Large Heat Sink				
I_D	Drain Current-Continuous	$T_C = 25^\circ\text{C}$	170	A
		$T_C = 100^\circ\text{C}$	108	A
P_D	Maximum Power Dissipation (Note 2)	130	W	
$R_{\theta JC}$	Thermal Resistance-Junction to Case	0.96	$^\circ\text{C}/\text{W}$	
$R_{\theta JA}$	Thermal Resistance Junction-Ambient (Note 3)	50	$^\circ\text{C}/\text{W}$	
Drain-Source Avalanche Ratings				
EAS	Avalanche Energy, Single Pulsed (Note 7)	256	mJ	

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit
Static Electrical Characteristics @ T_J=25°C (unless otherwise stated)						
V(BR)DSS	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	30	--	--	V
IDSS	Zero Gate Voltage Drain Current	V _{DS} =30V, V _{GS} =0V	--	--	1	μA
IGSS	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V	--	--	±100	nA
VGS(th)	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	1.3	1.8	2.3	V
RDS(on)	Drain-Source On-State Resistance	V _{GS} =10V, I _D =20A	--	0.92	1.15	mΩ
RDS(on)	Drain-Source On-State Resistance	V _{GS} =4.5V, I _D =15A	--	1.25	1.7	mΩ
Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise stated) (Note 5)						
Ciss	Input Capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz	--	5903	--	pF
Coss	Output Capacitance		--	3216	--	pF
Crss	Reverse Transfer Capacitance		--	204	--	pF
Rg	Gate Resistance	f=1MHz	--	1.3	--	Ω
Qg	Total Gate Charge	V _{DS} =15V, I _D =20A, V _{GS} =4.5V	--	40	--	nC
Qgs	Gate-Source Charge		--	23	--	nC
Qgd	Gate-Drain Charge		--	9.9	--	nC
Switching Characteristics (Note 5)						
Td(on)	Turn-on Delay Time	V _{DD} =20V, I _D =15A, R _G =3.0Ω, V _{GS} =4.5V	--	43	--	ns
Tr	Turn-on Rise Time		--	80	--	ns
Td(off)	Turn-Off Delay Time		--	52	--	ns
Tf	Turn-Off Fall Time		--	32	--	ns
Source- Drain Diode Characteristics @ T_J = 25°C (unless otherwise stated)						
IS	Diode Forward Current (Note 3)		--	--	170	A
VSD	Forward on voltage (Note 6)	I _S =10A, V _{GS} =0V	--	--	1.4	V
Trr	Reverse Recovery Time (Note 4)	T _J =25°C, I _S = I _F di/dt=100A/μs	--	67	--	ns
Qrr	Reverse Recovery Charge		--	90	--	nC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.
2. The power dissipation PD is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance.
3. Surface Mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C.
4. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
5. Guaranteed by design, not subject to production.
6. The maximum current limited by package
7. EAS condition : T_J=25°C, V_{DD}=15V, V_G=10V, L=0.5mH, R_g=25Ω

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

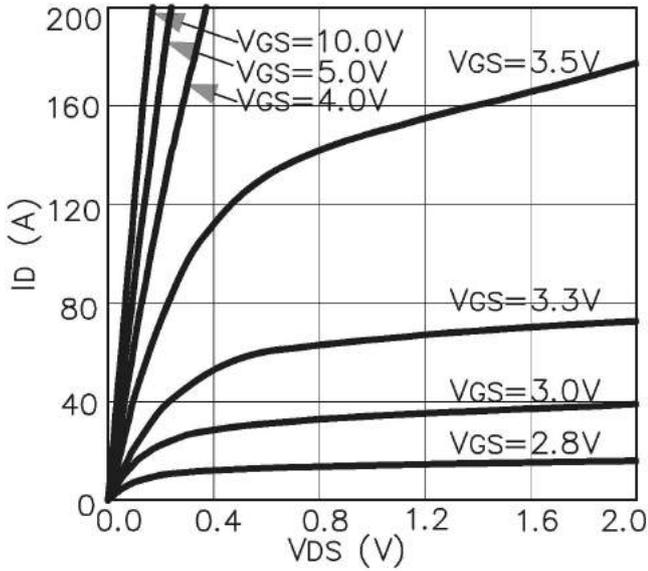


Figure 1 Output Characteristics

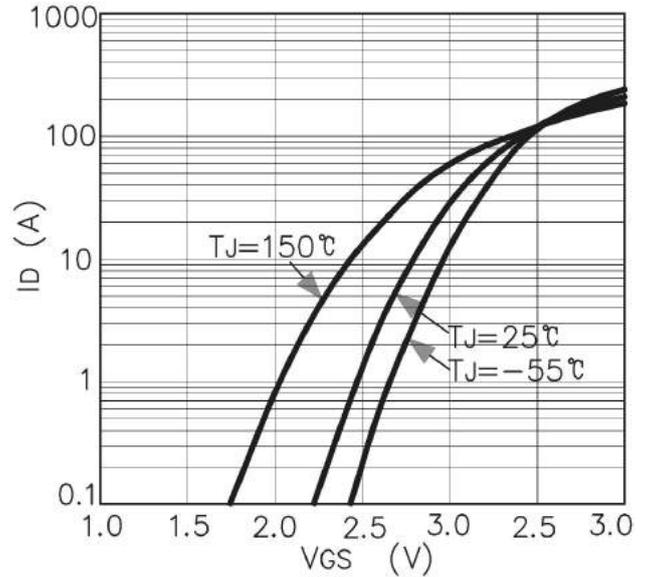


Figure 4 Transfer Characteristics

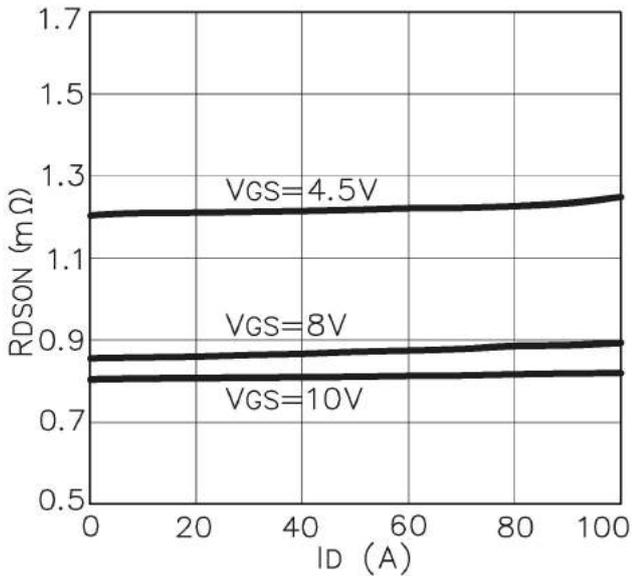


Figure 2 Rdson- Drain Current

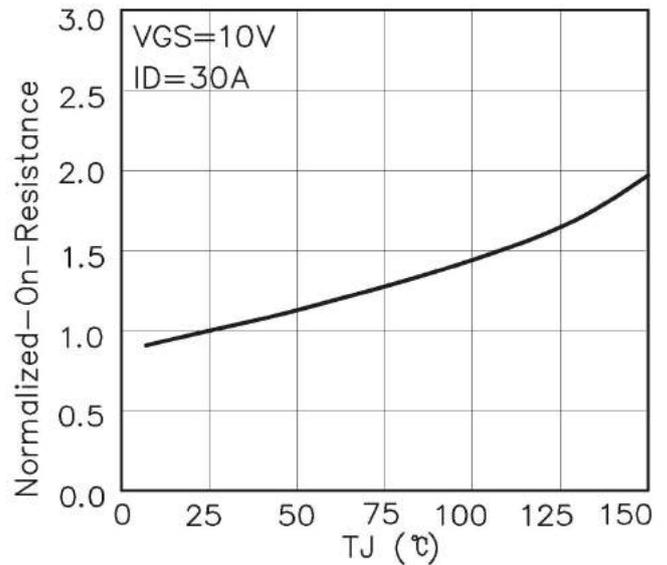


Figure 5 Rdson-Junction Temperature

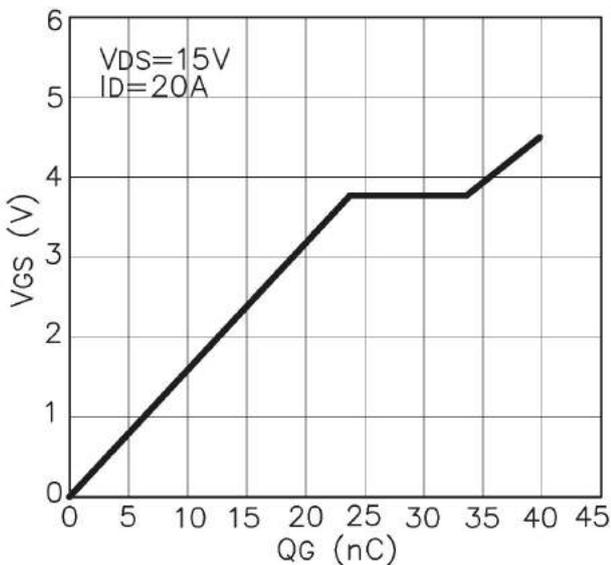


Figure 3 Gate Charge

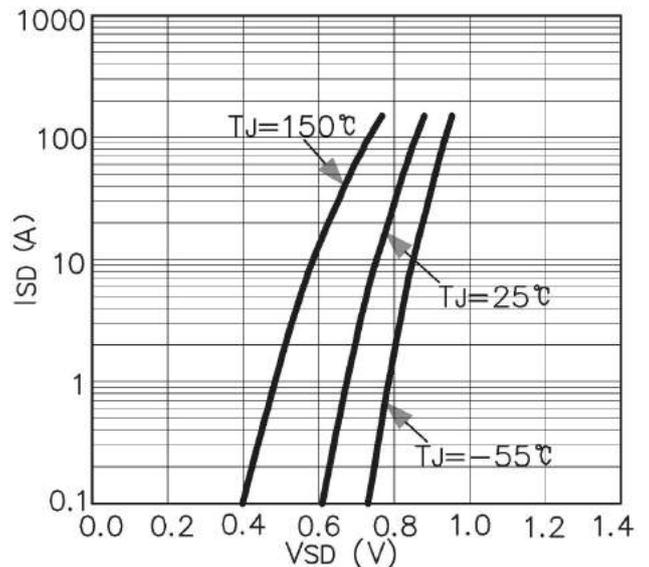


Figure 6 Source-Drain Diode Forward

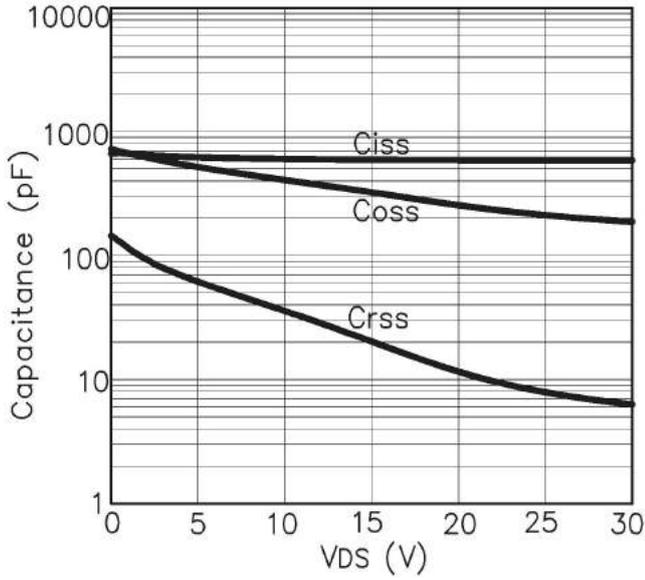


Figure 7 Capacitance vs Vds

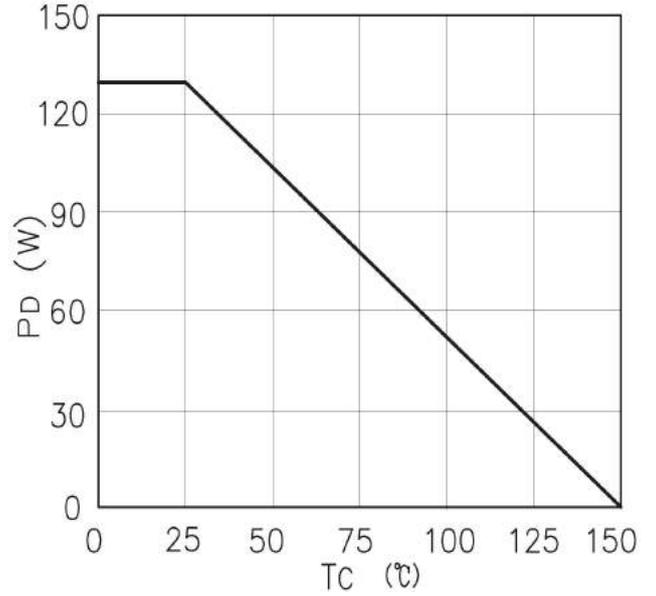


Figure 9 Power De-rating

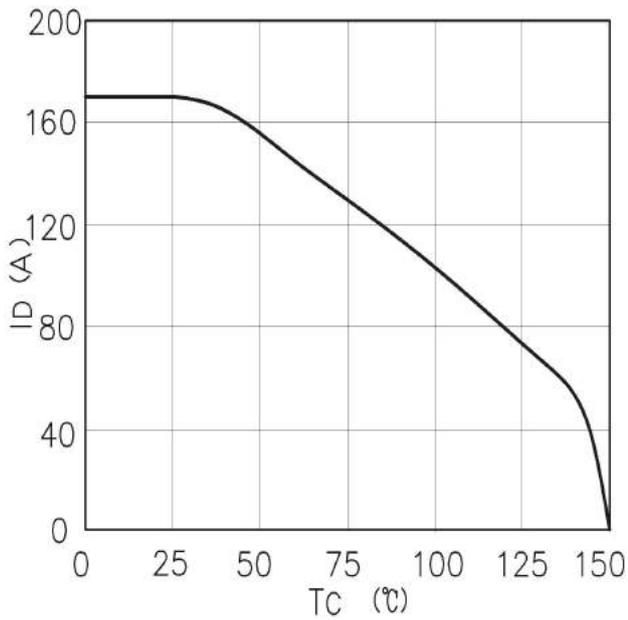


Figure 8 Current De-rating

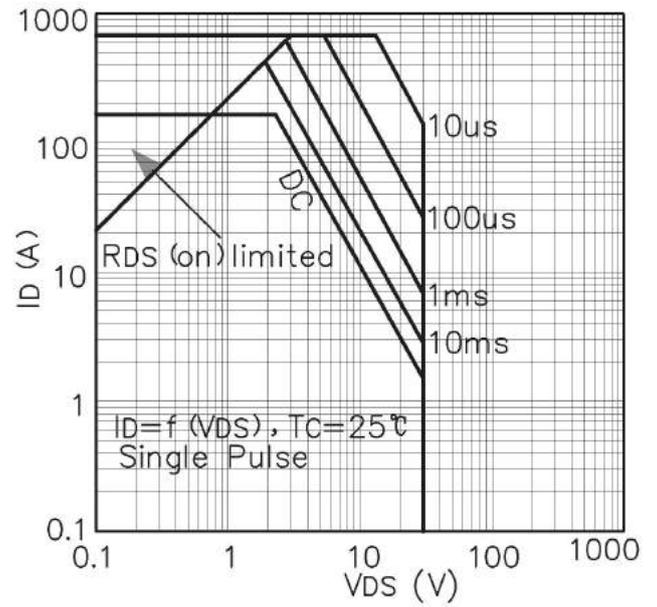
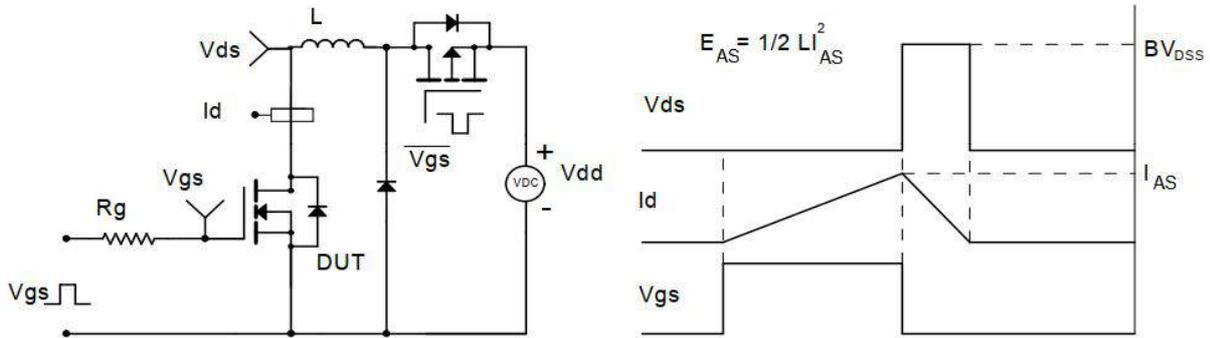


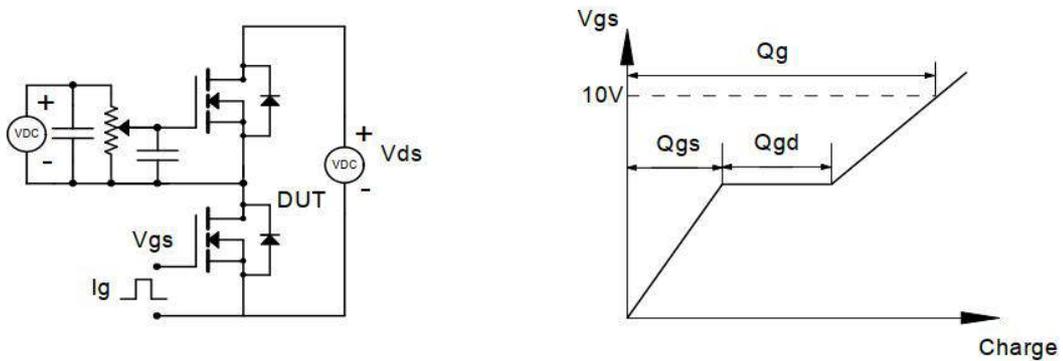
Figure 10 Safe Operation Area

Test circuit&Waveform

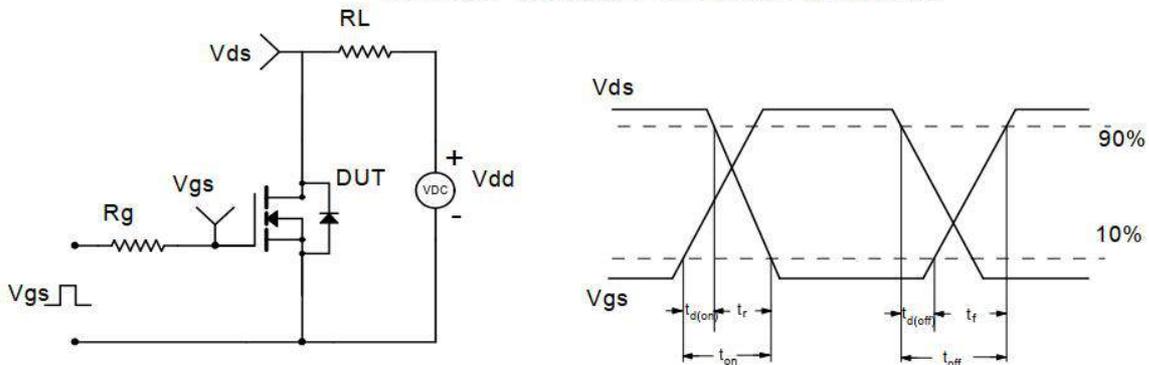
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



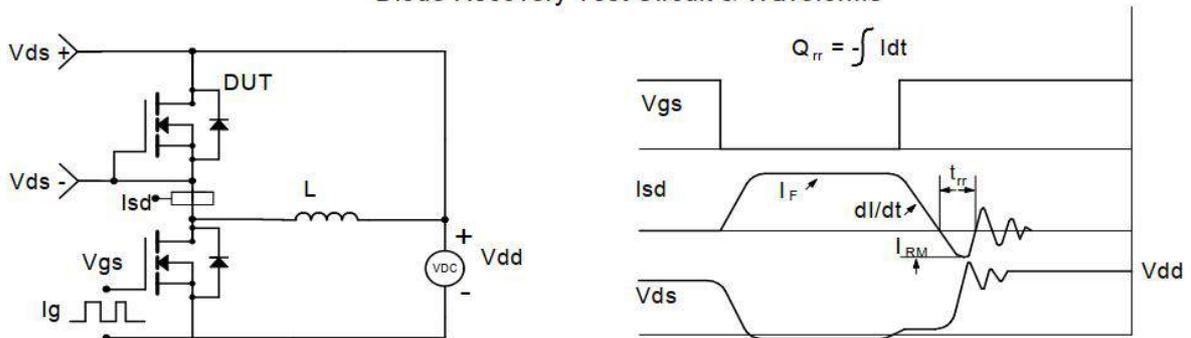
Gate Charge Test Circuit & Waveform



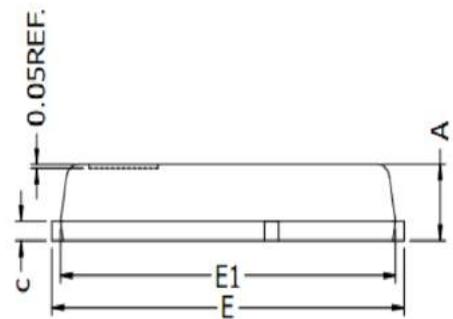
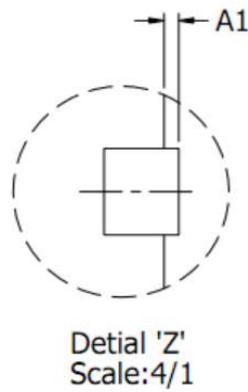
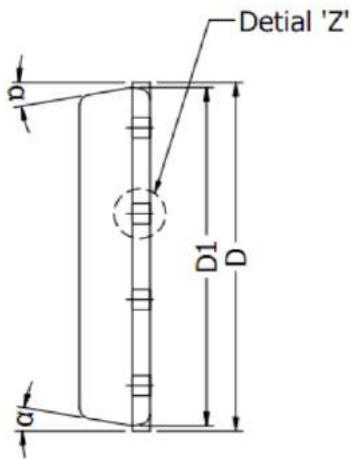
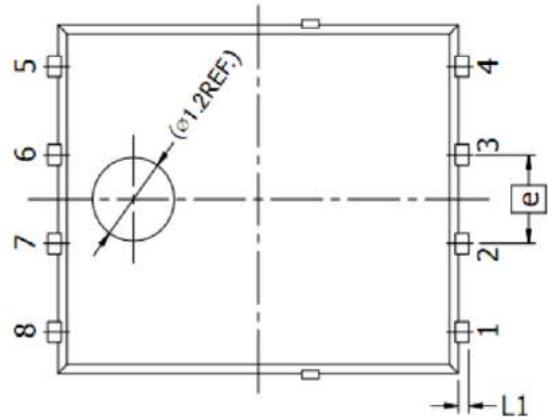
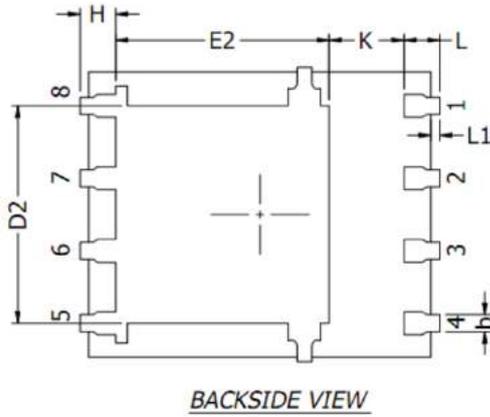
Resistive Switching Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



DFN5x6-8L Package Information



DIM.	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.00	1.10
A1	0	-	0.05
b	0.30	0.40	0.50
c	0.20	0.25	0.30
D	5.15 BSC		
D1	5.00 BSC		
D2	3.76	3.81	3.86
E	6.15 BSC		
E1	5.80	5.85	5.90
E2	3.45	3.65	3.85
e	1.27 BSC		
H	0.51	0.61	0.71
K	1.10	-	-
L	0.51	0.61	0.71
L1	0.08	0.15	0.23
α	10°	11°	12°

Customer Service

Sales and Service:
zj@ztasemi.com